

## P-Channel 200V (D-S) MOSFET

| PRODUCT SUMMARY           |                         |     |
|---------------------------|-------------------------|-----|
| $V_{DS}$ (V)              | -200                    |     |
| $R_{DS(on)}$ ( $\Omega$ ) | $V_{GS} = -10\text{ V}$ | 2.0 |
| $Q_g$ max. (nC)           | 44                      |     |
| $Q_{gs}$ (nC)             | 7.1                     |     |
| $Q_{gd}$ (nC)             | 27                      |     |
| Configuration             | Single                  |     |

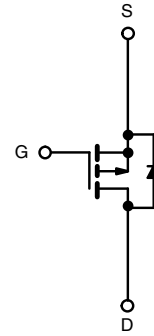
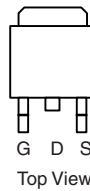
### FEATURES

- Dynamic dV/dt rating
- Repetitive avalanche rated
- P-channel
- Fast switching
- Ease of paralleling
- Simple drive requirements



Available  
**RoHS\***  
 Available

TO-263



P-Channel MOSFET

| ABSOLUTE MAXIMUM RATINGS (T <sub>C</sub> = 25 °C, unless otherwise noted) |                          |                         |                                   |                |          |   |
|---------------------------------------------------------------------------|--------------------------|-------------------------|-----------------------------------|----------------|----------|---|
| PARAMETER                                                                 |                          |                         | SYMBOL                            | LIMIT          | UNIT     |   |
| Drain-Source Voltage                                                      |                          |                         | V <sub>DS</sub>                   | -200           | V        |   |
| Gate-Source Voltage                                                       |                          |                         | V <sub>GS</sub>                   | ± 20           | V        |   |
| Continuous Drain Current                                                  | V <sub>GS</sub> at -10 V | T <sub>C</sub> = 25 °C  | I <sub>D</sub>                    | -4             | A        |   |
|                                                                           |                          | T <sub>C</sub> = 100 °C |                                   | -2             |          |   |
| Pulsed Drain Current <sup>a</sup>                                         |                          |                         | I <sub>DM</sub>                   | -8             |          |   |
| Linear Derating Factor                                                    |                          |                         |                                   | 1.0            | W/°C     |   |
| Single Pulse Avalanche Energy <sup>b</sup>                                |                          |                         | E <sub>AS</sub>                   | 400            | mJ       |   |
| Repetitive Avalanche Current <sup>a</sup>                                 |                          |                         | I <sub>AR</sub>                   | -3             | A        |   |
| Repetitive Avalanche Energy <sup>a</sup>                                  |                          |                         | E <sub>AR</sub>                   | 10             | mJ       |   |
| Maximum Power Dissipation                                                 |                          | T <sub>C</sub> = 25 °C  |                                   | P <sub>D</sub> | 105      | W |
| Peak Diode Recovery dV/dt <sup>c</sup>                                    |                          |                         | dV/dt                             | -5.0           | V/ns     |   |
| Operating Junction and Storage Temperature Range                          |                          |                         | T <sub>J</sub> , T <sub>stg</sub> | -55 to +150    | °C       |   |
| Soldering Recommendations (Peak temperature) <sup>d</sup>                 |                          | for 10 s                |                                   | 300            |          |   |
| Mounting Torque                                                           | 6-32 or M3 screw         |                         |                                   | 10             | lbf · in |   |
|                                                                           |                          |                         |                                   | 1.1            | N · m    |   |

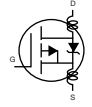
### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).  
 b.  $V_{DD} = -50\text{ V}$ , starting  $T_J = 25\text{ }^{\circ}\text{C}$ ,  $L = 8.7\text{ mH}$ ,  $R_g = 25\text{ }\Omega$ ,  $I_{AS} = -11\text{ A}$  (see fig. 12).  
 c.  $I_{SD} \leq -11\text{ A}$ ,  $dI/dt \leq 150\text{ A}/\mu\text{s}$ ,  $V_{DD} \leq V_{DS}$ ,  $T_J \leq 150\text{ }^{\circ}\text{C}$ .  
 d. 1.6 mm from case.

**THERMAL RESISTANCE RATINGS**

| PARAMETER                           | SYMBOL     | TYP. | MAX. | UNIT |
|-------------------------------------|------------|------|------|------|
| Maximum Junction-to-Ambient         | $R_{thJA}$ | -    | 62   | °C/W |
| Case-to-Sink, Flat, Greased Surface | $R_{thCS}$ | 0.50 | -    |      |
| Maximum Junction-to-Case (Drain)    | $R_{thJC}$ | -    | 1.0  |      |

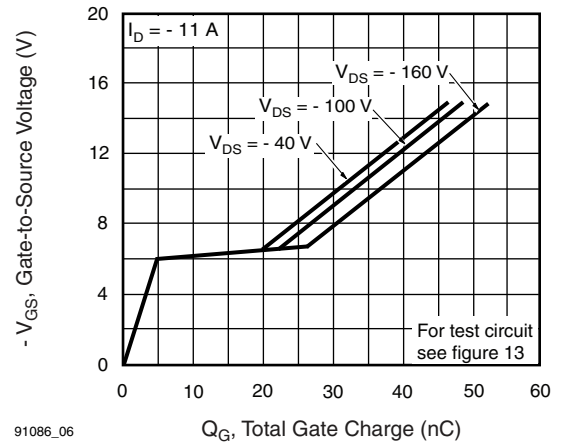
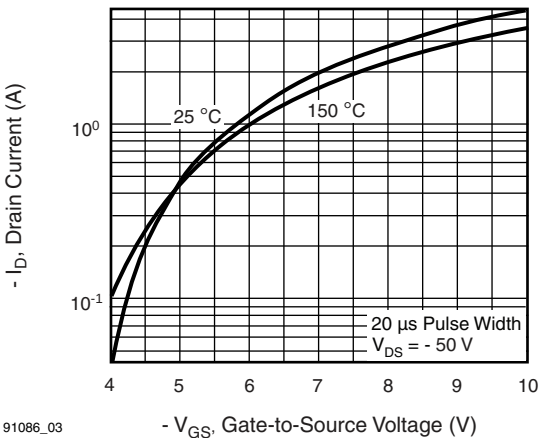
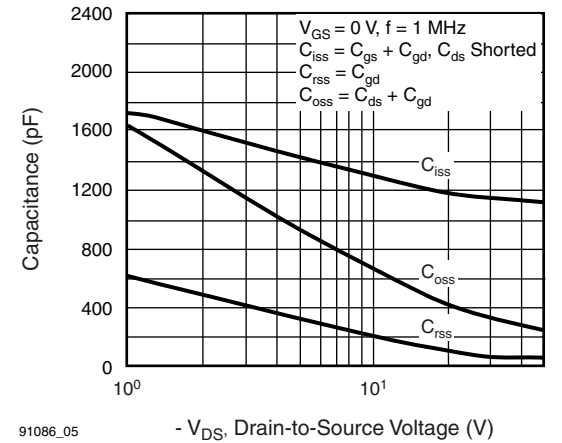
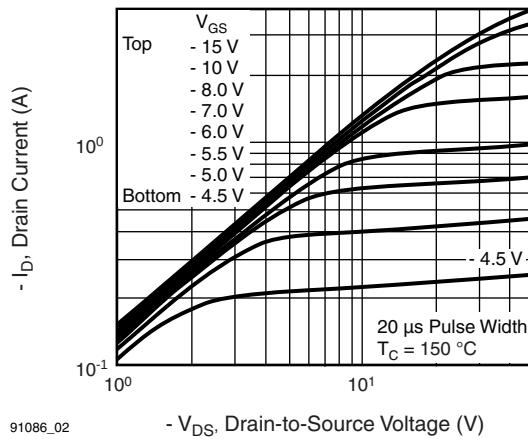
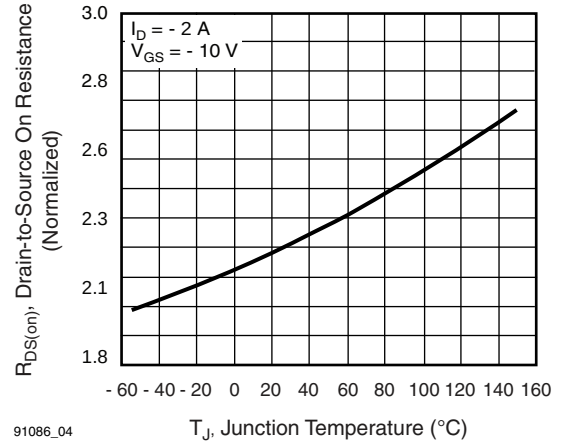
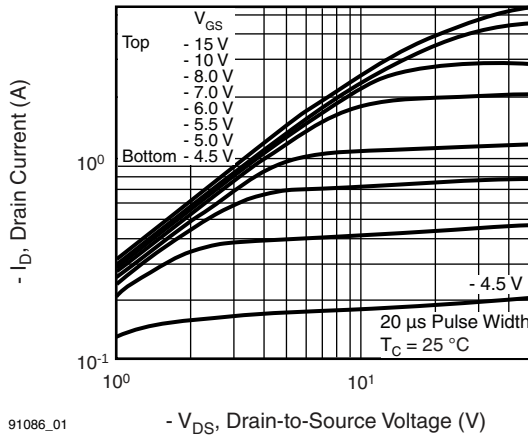
**SPECIFICATIONS** ( $T_J = 25\text{ }^{\circ}\text{C}$ , unless otherwise noted)

| PARAMETER                                      | SYMBOL              | TEST CONDITIONS                                                                                                                                                     | MIN. | TYP. | MAX.     | UNIT                  |
|------------------------------------------------|---------------------|---------------------------------------------------------------------------------------------------------------------------------------------------------------------|------|------|----------|-----------------------|
| <b>Static</b>                                  |                     |                                                                                                                                                                     |      |      |          |                       |
| Drain-Source Breakdown Voltage                 | $V_{DS}$            | $V_{GS} = 0\text{ V}$ , $I_D = -250\text{ }\mu\text{A}$                                                                                                             | -200 | -    | -        | V                     |
| $V_{DS}$ Temperature Coefficient               | $\Delta V_{DS}/T_J$ | Reference to $25\text{ }^{\circ}\text{C}$ , $I_D = -1\text{ mA}$                                                                                                    | -    | -0.2 | -        | V/ $^{\circ}\text{C}$ |
| Gate-Source Threshold Voltage                  | $V_{GS(th)}$        | $V_{DS} = V_{GS}$ , $I_D = -250\text{ }\mu\text{A}$                                                                                                                 | -1.5 | -    | -4.0     | V                     |
| Gate-Source Leakage                            | $I_{GSS}$           | $V_{GS} = \pm 20\text{ V}$                                                                                                                                          | -    | -    | $\pm 10$ | $\mu\text{A}$         |
| Zero Gate Voltage Drain Current                | $I_{DSS}$           | $V_{DS} = -200\text{ V}$ , $V_{GS} = 0\text{ V}$                                                                                                                    | -    | -    | -100     | $\mu\text{A}$         |
|                                                |                     | $V_{DS} = -160\text{ V}$ , $V_{GS} = 0\text{ V}$ , $T_J = 125\text{ }^{\circ}\text{C}$                                                                              | -    | -    | -500     |                       |
| Drain-Source On-State Resistance               | $R_{DS(on)}$        | $V_{GS} = -10\text{ V}$ , $I_D = -2.0\text{ A}^b$                                                                                                                   | -    | 2.0  | -        | $\Omega$              |
| Forward Transconductance                       | $g_{fs}$            | $V_{DS} = -50\text{ V}$ , $I_D = -2.0\text{ A}^b$                                                                                                                   | 4.1  | -    | -        | S                     |
| <b>Dynamic</b>                                 |                     |                                                                                                                                                                     |      |      |          |                       |
| Input Capacitance                              | $C_{iss}$           | $V_{GS} = 0\text{ V}$ ,<br>$V_{DS} = -25\text{ V}$ ,<br>$f = 1.0\text{ MHz}$ , see fig. 5                                                                           | -    | 700  | -        | pF                    |
| Output Capacitance                             | $C_{oss}$           |                                                                                                                                                                     | -    | 370  | -        |                       |
| Reverse Transfer Capacitance                   | $C_{rss}$           |                                                                                                                                                                     | -    | 81   | -        |                       |
| Total Gate Charge                              | $Q_g$               | $V_{GS} = -10\text{ V}$ , $I_D = -2\text{ A}$ , $V_{DS} = -160\text{ V}$ ,<br>see fig. 6 and 13 <sup>b</sup>                                                        | -    | -    | 44       | nC                    |
| Gate-Source Charge                             | $Q_{gs}$            |                                                                                                                                                                     | -    | -    | 7.1      |                       |
| Gate-Drain Charge                              | $Q_{gd}$            |                                                                                                                                                                     | -    | -    | 27       |                       |
| Turn-On Delay Time                             | $t_{d(on)}$         | $V_{DD} = -100\text{ V}$ , $I_D = -2\text{ A}$<br>$R_g = 9.1\text{ }\Omega$ , $R_D = 8.6\text{ }\Omega$ , see fig. 10 <sup>b</sup>                                  | -    | 14   | -        | ns                    |
| Rise Time                                      | $t_r$               |                                                                                                                                                                     | -    | 43   | -        |                       |
| Turn-Off Delay Time                            | $t_{d(off)}$        |                                                                                                                                                                     | -    | 39   | -        |                       |
| Fall Time                                      | $t_f$               |                                                                                                                                                                     | -    | 38   | -        |                       |
| Internal Drain Inductance                      | $L_D$               | Between lead,<br>6 mm (0.25") from<br>package and center of<br>die contact<br> | -    | 4.5  | -        | nH                    |
| Internal Source Inductance                     | $L_S$               |                                                                                                                                                                     | -    | 7.5  | -        |                       |
| Gate Input Resistance                          | $R_g$               | $f = 1\text{ MHz}$ , open drain                                                                                                                                     | 0.3  | -    | 1.7      | $\Omega$              |
| <b>Drain-Source Body Diode Characteristics</b> |                     |                                                                                                                                                                     |      |      |          |                       |
| Continuous Source-Drain Diode Current          | $I_S$               | MOSFET symbol<br>showing the<br>integral reverse<br>p-n junction diode<br>     | -    | -    | -2       | A                     |
| Pulsed Diode Forward Current <sup>a</sup>      | $I_{SM}$            |                                                                                                                                                                     | -    | -    | -4       |                       |
| Body Diode Voltage                             | $V_{SD}$            | $T_J = 25\text{ }^{\circ}\text{C}$ , $I_S = -2\text{ A}$ , $V_{GS} = 0\text{ V}^b$                                                                                  | -    | -    | -5       | V                     |
| Body Diode Reverse Recovery Time               | $t_{rr}$            | $T_J = 25\text{ }^{\circ}\text{C}$ , $I_F = -11\text{ A}$ , $dI/dt = 100\text{ A}/\mu\text{s}^b$                                                                    | -    | 250  | 300      | ns                    |
| Body Diode Reverse Recovery Charge             | $Q_{rr}$            |                                                                                                                                                                     | -    | 2.9  | 3.6      | $\mu\text{C}$         |
| Forward Turn-On Time                           | $t_{on}$            | Intrinsic turn-on time is negligible (turn-on is dominated by $L_S$ and $L_D$ )                                                                                     |      |      |          |                       |

**Notes**

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).  
 b. Pulse width  $\leq 300\text{ }\mu\text{s}$ ; duty cycle  $\leq 2\%$ .

**TYPICAL CHARACTERISTICS** (25 °C, unless otherwise noted)



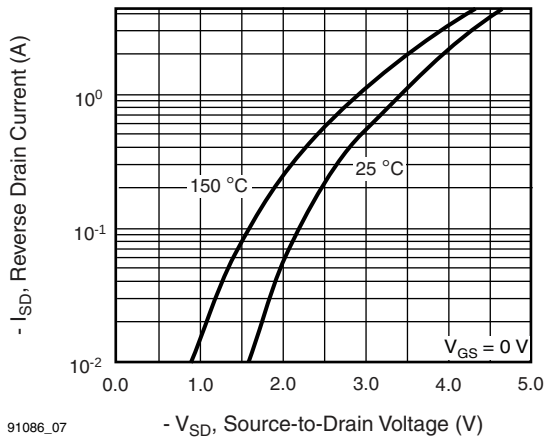


Fig. 7 - Typical Source-Drain Diode Forward Voltage

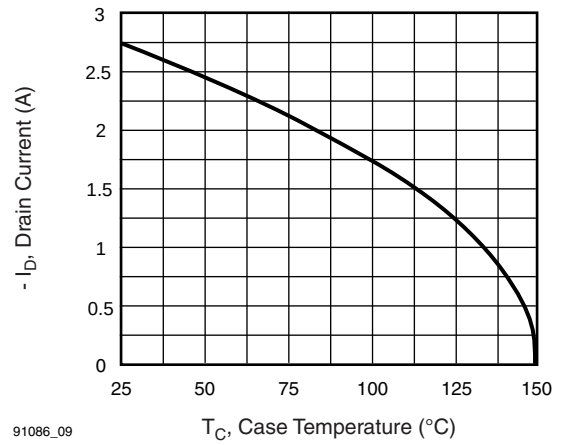


Fig. 9 - Maximum Drain Current vs. Case Temperature

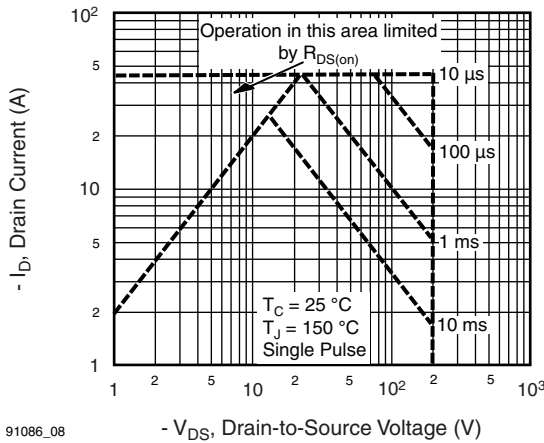


Fig. 8 - Maximum Safe Operating Area

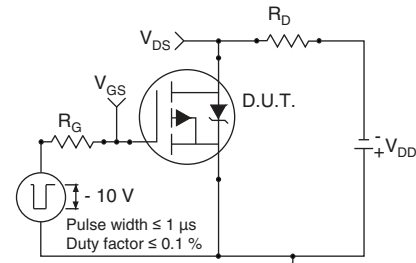


Fig. 10a - Switching Time Test Circuit

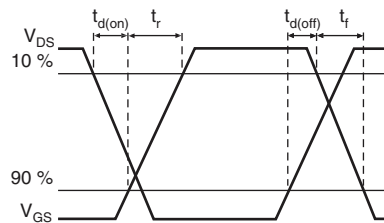


Fig. 10b - Switching Time Waveforms

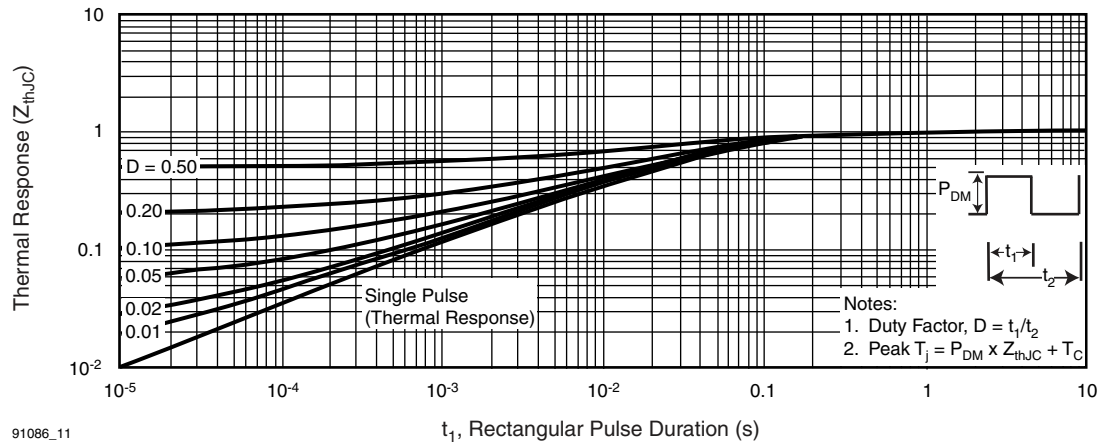


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

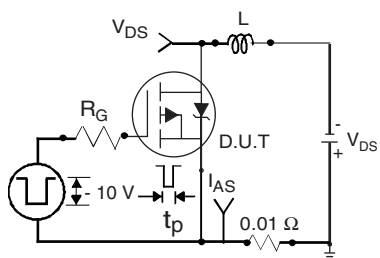


Fig. 12a - Unclamped Inductive Test Circuit

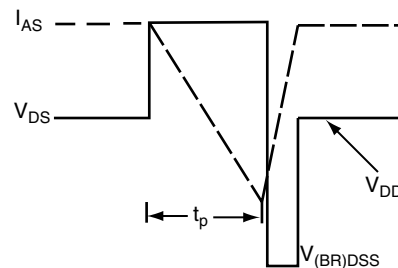


Fig. 12b - Unclamped Inductive Waveforms

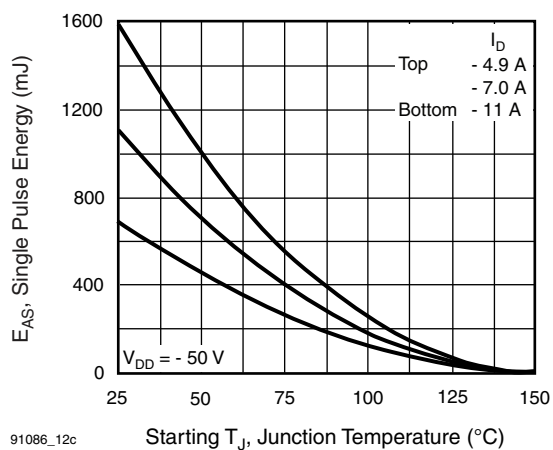


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

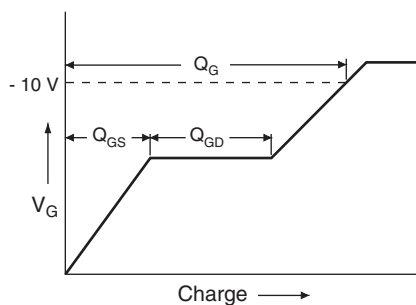


Fig. 13a - Basic Gate Charge Waveform

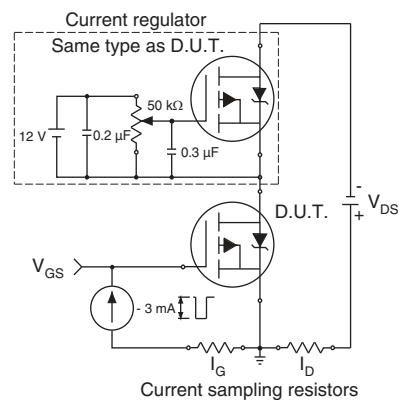
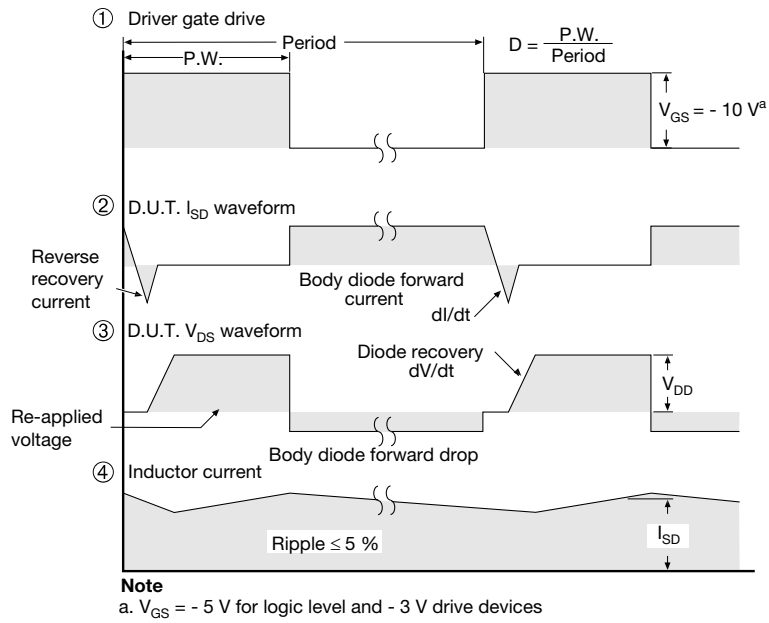
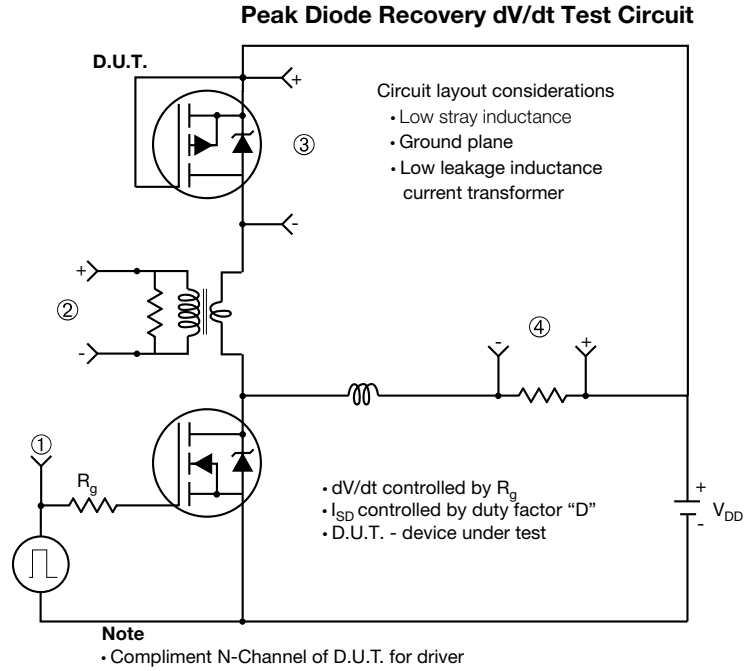
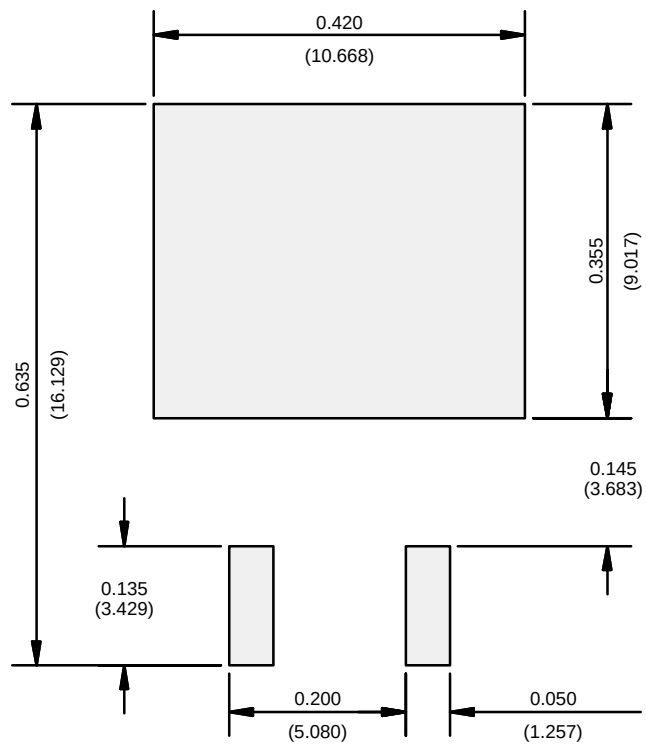


Fig. 13b - Gate Charge Test Circuit



**Fig. 14 - For P-Channel**

**RECOMMENDED MINIMUM PADS FOR D<sup>2</sup>PAK: 3-Lead**

Recommended Minimum Pads  
Dimensions in Inches/(mm)

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